Application/Control No.	Applicant(s)/Patent under Reexamination	
10/801,637	NAKAYAMA ET AL.	
Examiner	Art Unit	
Cynthia Lee	1745	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE E	XMR		
inventor search	2/6/2007	CL		
EAST search - see printout	2/6/2007	CL		